

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/678,893	CHANG ET AL.	
Examiner		Art Unit		Page 1 of 1
Sheng-Jen Tsai		2186		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0042230	11-2001	Williams et al.	714/703
*	B	US-5,956,743	09-1999	Bruce et al.	711/103
*	C	US-6,182,239	01-2001	Kramer, Alan	714/5
*	D	US-5,228,046	07-1993	Blake et al.	714/761
*	E	US-6,000,006	12-1999	Bruce et al.	711/103
*	F	US-6,487,685	11-2002	Stuart Fiske et al.	714/701
*	G	US-2004/0228197	11-2004	Mokhlesi, Nima	365/232
*	H	US-5,603,001	02-1997	Sukegawa et al.	711/103
*	I	US-5,754,565	05-1998	Mo et al.	714/769
*	J	US-2002/0008928	01-2002	TAKAHASHI, TSUYOSHI	360/53
*	K	US-6,970,890	11-2005	Bruce et al.	707/202
*	L	US-2001/0029564	10-2001	Estakhri et al.	711/103
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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